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LICENCE HOLDER

GigaDevice Semiconductor Inc.
10/F, 1ST TO 5TH FLOOR, BUILDING 9, NO. 8
FENGHAO EAST ROAD, HAIDIAN DISTRICT, 100094
BEIJING, P.R. CHINA

Project No.: [illegible] **LICENSED TEST MARK** **Report No.:** NA

V1TL **V1TL 0003**

ASIL D READY
Functional Safety
www.sgs-tuev-saar.com

Tested according to: ISO 26262-5: 2018 (Clause 9 and 10)

Certified Product: GD32H7 Serial MCUs: Basic, Performance, Connectivity

Technical Data/Parameter

The above-mentioned product has been approved based on the safety assessment of a reference configuration (see certification report for details).
The architectural metrics SPFM (Single Point Fault Metric) and LFM (Latent Fault Metric), as well as the estimated PMHF (Probabilistic Metric for random Hardware Failures) are in conformance with the ASIL D target values.

Specific Requirements

The certificate is only approved and issued on a related functional safety assessment. Any changes to the design, materials, components or processes may invalidate the approval of some or the assessment steps in order to maintain approval.
The certificate report is an integral part of this certificate. All requirements and specifications of the current valid revision of this report shall be met.

Certification Body for Functional Safety
SGS-TÜV Saar GmbH

Pfaffenhein, Nov. 8th, 2024

Marcus Kraus

The validation status of this certificate is documented via SGS Certification Database

The test mark regulation is an integral part of this certificate.

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